

DATA SHEET

2.45 GHz Multilayer Ceramic Balun (2012)

9th, Jan.2004 Rev.5

2012/2.45GHz 50-200 ohm Multilayer Ceramic Balun				CBA4711714022454K				—	1	12 th , Feb.2003	
								▶	2	14 th , Apr. 2003	
								—	3	23th, May.2003	
BY / 製定者	J.S.Hsieh	SUPER / 原圖編號	C.T. Lee	TLL.SH / 共頁	12	PAGE/ 頁	1	SH nr. 190	—	4	6 th , Aug.2003
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**MULTILAYER CERAMIC BALUN
FOR BLUETOOTH & WLAN IEEE 802.11b/g (2.45GHz ISM Band)
Product Specification¹**

QUICK REFERENCE DATA

Specifications

Frequency Range	2400-2500 MHz
Unbalanced Impedance	50 Ohm
Balanced Impedance	200 Ohm
Unbalanced port V.S.W.R. (Return Loss)	2.0 (Max) 10dB (Min)
Insertion Loss	1 dB (Max) at 25 Deg. C 1.3 dB (Max) at -40 ~ +85 Deg. C
Ripple	0.6dB
Phase Difference	180 ±10 degree
Amplitude Difference	2.0 dB (Max)
Dimension	2.0 x 1.25 x 0.8 mm

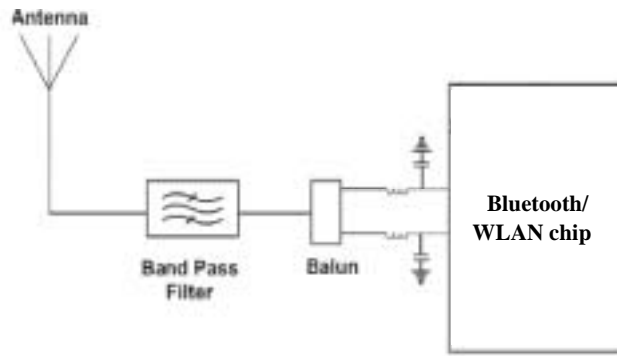


Special Environmental Concerns- Green Products Design: Termination is lead free (Pb free) and packing materials can be re-cycled

¹ All the technical data and information contained herein are subject to change without prior notice

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Applications



Dimensions and Port Configurations

Figure	Dimension	Port
	L 2.0±0.15mm W 1.25±0.15mm T 0.8±0.15mm P1 0.3±0.15mm P2 0.3±0.15mm P3 0.3±0.15mm P4 0.3±0.15mm P5 0.3±0.15mm P6 0.3±0.15mm D1 0.2±0.15mm D2 0.65±0.15mm D3 0.35±0.15mm D4 0.3±0.15mm	Unbal. Port Ground or DC Balanced Port Balanced Port Ground Not Connect

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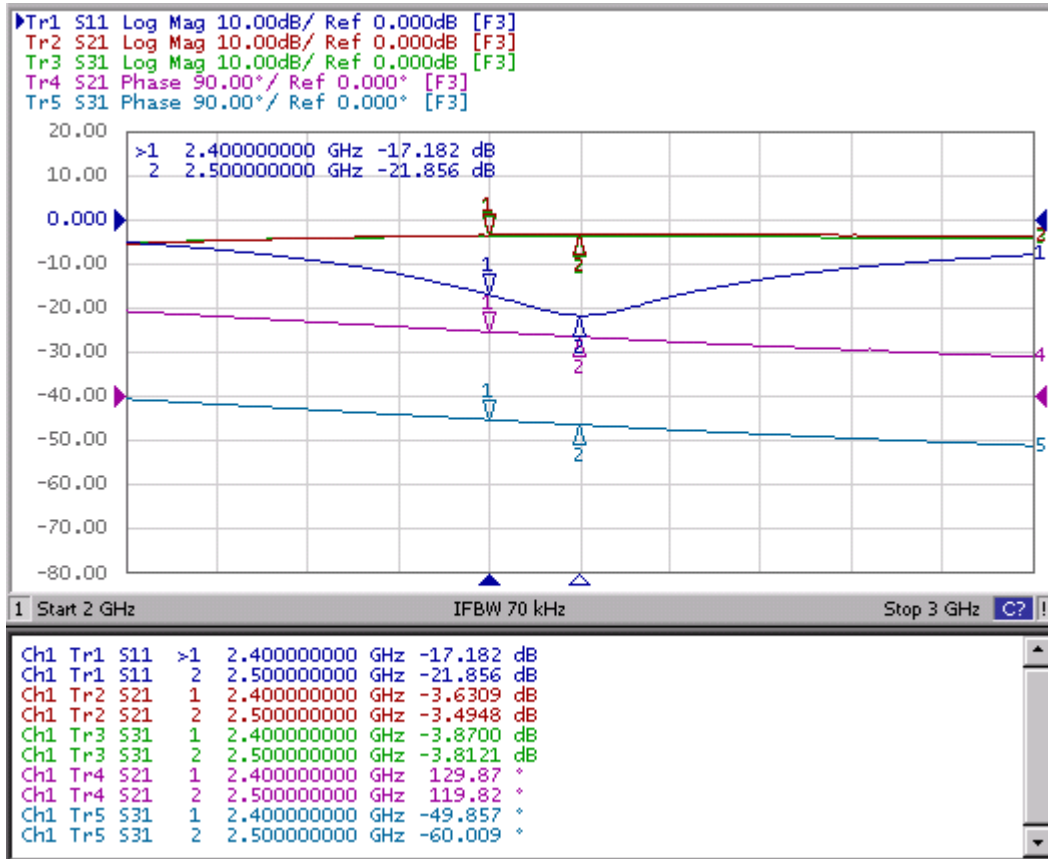
Recommended PCB Pattern

Figure	Dimension	Remark												
	<table border="0"> <tr> <td>D1</td> <td>1.0 ±0.1mm</td> </tr> <tr> <td>D2</td> <td>0.8 ±0.1mm</td> </tr> <tr> <td>D3</td> <td>0.35 ±0.1mm</td> </tr> <tr> <td>D4</td> <td>0.65 ±0.1mm</td> </tr> <tr> <td>D5</td> <td>0.25 ±0.1mm</td> </tr> <tr> <td>D6</td> <td>0.25 ±0.1mm</td> </tr> </table>	D1	1.0 ±0.1mm	D2	0.8 ±0.1mm	D3	0.35 ±0.1mm	D4	0.65 ±0.1mm	D5	0.25 ±0.1mm	D6	0.25 ±0.1mm	<p>Land Through hole</p>
D1	1.0 ±0.1mm													
D2	0.8 ±0.1mm													
D3	0.35 ±0.1mm													
D4	0.65 ±0.1mm													
D5	0.25 ±0.1mm													
D6	0.25 ±0.1mm													

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Frequency Characteristics (I)

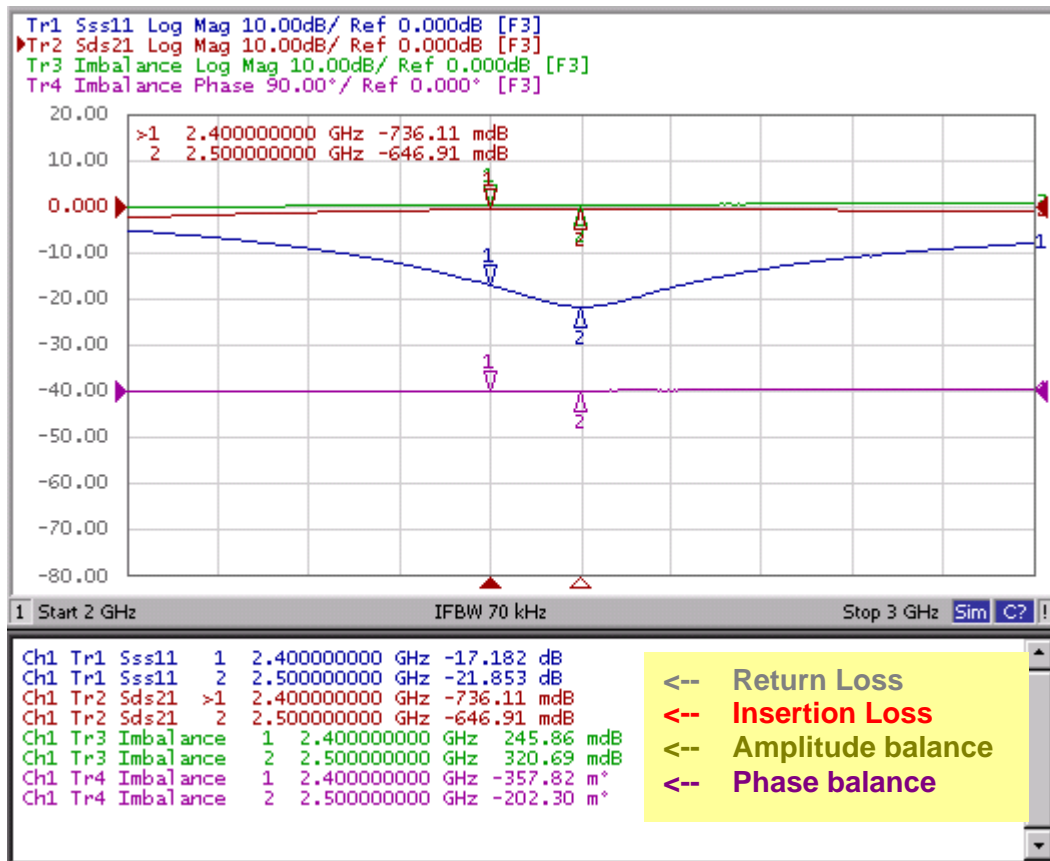
S11, S21, S31 Measured on Agilent E5071A Network Analyzer



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Frequency Characteristics (II)

Insertion loss (Sds21, differential port to single-ended port) and Imbalance (S21/S31 amplitude and phase difference) measured on Agilent E5071A Network Analyzer



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RELIABILITY DATA (Reference to IEC Specification)

IEC 384-10/ CECC 32 100 CLAUSE	IEC 60068-2 TEST METHOD	TEST	PROCEDURE	REQUIREMENTS
4.4		Mounting	The balun can be mounted on printed-circuit boards or ceramic substrates by applying wave soldering, reflow soldering (including vapour phase soldering) or conductive adhesive	No visible damage
4.5		Visual inspection and dimension check	Any applicable method using $\times 10$ magnification	In accordance with specification (chip off 1mm)
4.6.1		Balun	VSWR < 2 at 20 °C	Standard test board
4.8		Adhesion	A force of 3 N applied for 10 s to the line joining the terminations and in a plane parallel to the substrate	No visible damage
4.9		Bond strength of plating on end face	Mounted in accordance with CECC 32 100, paragraph 4.4	No visible damage
			Conditions: bending 0.5 mm at a rate of 1mm/s, radius jig. 340 mm, 2mm warp on FR4 board of 90 mm length	No visible damage
4.10	20(Tb)	Resistance to soldering heat	260 \pm 5 °C for 10 \pm 0.5 s in a static solder bath	No visible damage and complies with electrical performance

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IEC 384-10/ CECC 32 100 CLAUSE	IEC 60068-2 TEST METHOD	TEST	PROCEDURE	REQUIREMENTS
		Resistance to leaching	260 ± 5 °C for 30 ± 1 s in a static solder bath	Using visual enlargement of × 10, dissolution of the termination shall not exceed 10%
4.11	20(Ta)	Solderability	Zero hour test, and test after storage (20 to 24 months) in original atmosphere; un-mounted chips completely immersed for 2 ± 0.5 s in 235 ± 5°C.	The termination must be well tinned, at least 75% is well tinned at termination
4.12	4(Na)	Rapid change of temperature	-40 °C (30 minutes) to +85 °C (30 minutes); 200 cycles	No visible damage and complies with electrical performance
4.13	IEC 60384-10	Climate sequence	1. Initial measurement 2. Dry Heat (16hours, 85deg. C) 3. Damp heat, cycle, Test Db first cycle (24hours; 55deg.C; 95 to 100% R.H.) 4. Cold(-20deg.C, 2hours) 5. Damp heat, cycle, Test Db, remaining 6. Final measurements	No visible damage and complies with electrical performance
4.14	3(Ca)	Damp heat	500 ± 12 hours at 40 °C; 90 to 95 % RH	No visible damage and complies with electrical performance
4.15		Endurance	500 ± 12 hours at 85 °C;	No visible damage and complies with electrical performance

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ORDERING INFORMATION:

These code numbers can be determined by the following rules:

4711 7 14 02 245
 F C M S T A

F. Family Code

47 = Balun

C. Packing Type Code

11 = 180 mm/ 7" blister

M. Materials Code

7 = High Frequency Material

S. Size Code

11 = 3.2 * 2.5

12 = 3.2 * 1.6

13 = 2.5 * 2.0

14 = 2.0 * 1.2

15 = 1.6 * 0.8

T. Type

00 = Unbalanced and balanced impedance, Type 1: 50 Ohm –50 Ohm

01 = Unbalanced and balanced impedance, Type 2: 50 Ohm –100 Ohm

02 = Unbalanced and balanced impedance, Type 3: 50 Ohm –200 Ohm

A. Working Frequency

245 = 2.45 GHz

ORDERING INFORMATION: Method - by Clear Text Code

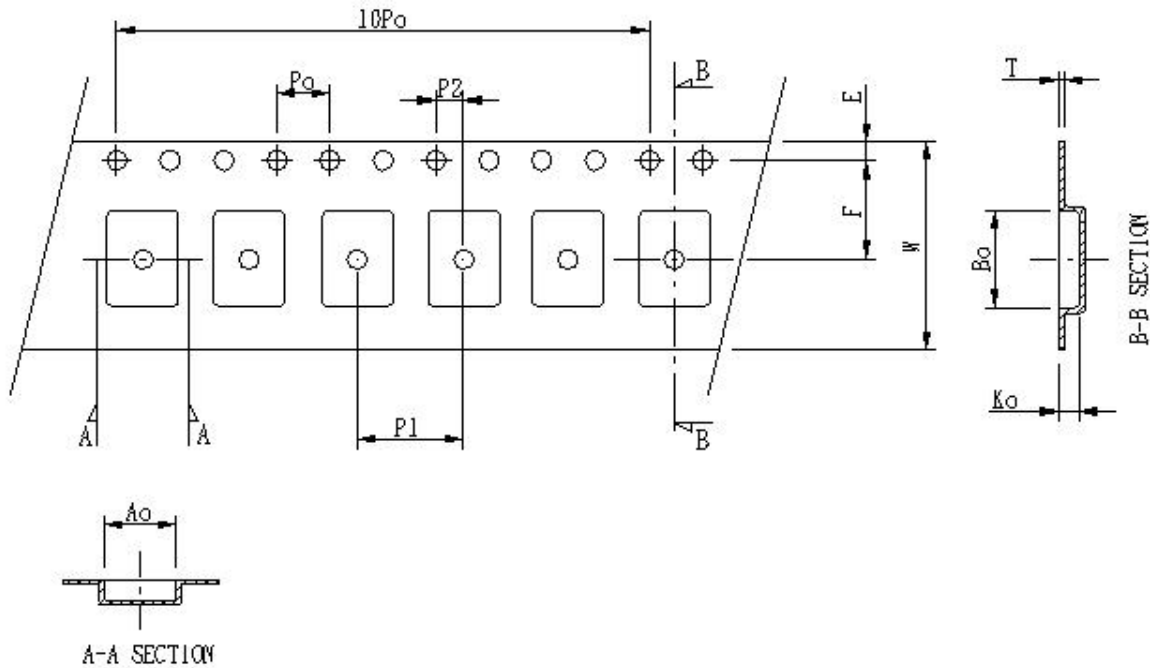
The baluns may be ordered by using the 17-digit clear text ordering code. These code numbers can be determined by the following rules:

CBA4711714002454K (Clear Text Code Example)

CBA47	11	7	14	02	245	4	K
Product	Packing type	Material	Size	Type	Central Frequency	Quantities	Packing
CBA47= Balun	180mm/7"	LTCC material	14=2.0*1.25 mm	02= Balun	245=2.45GHz	4= 4K pcs	K=7" plastic

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Taping Blister Tape

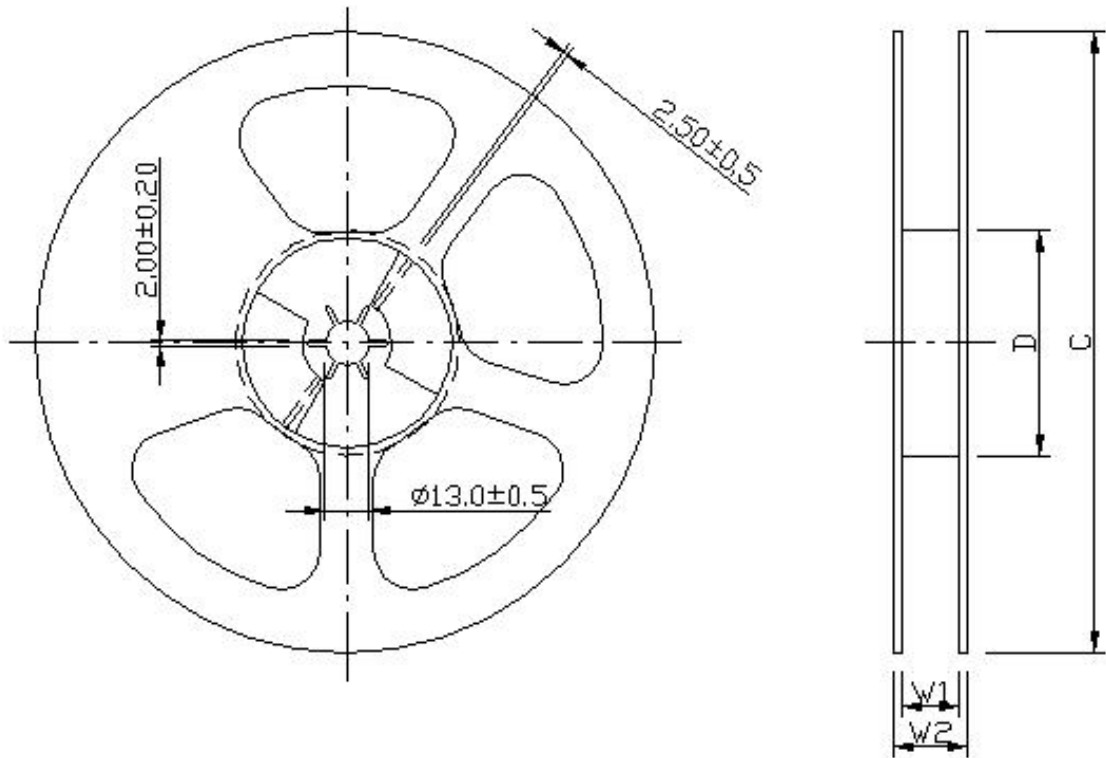


DIMENSION:

Serial no	Checking note	Index	Spec(mm)
1	Sprocket hole	Do	1.50±0.10
2	Pocket hole	D1	≥1
3	Distance sprocket hole/sprocket hole	Po	4.0±0.10
4	Distance pocket/pocket	P1	4.0±0.10
5	Distance sprocket hole/pocket	P2	2.0±0.10
6	Tape width	W	8.1±0.20
7	Distance sprocket hole/outside	E	1.75±0.10
8	Distance sprocket hole/pocket	F	3.5±0.05
9	Pocket length nominal clearance	Ao	1.42±0.10
10	Pocket length nominal clearance	Bo	2.24±0.10
11	Pocket depth minimum clearance	Ko	1.04±0.10
12	Thickness of tape	T	0.22±0.05
13	10x sprocket hole pitch	10Po	40.0±0.20

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7”(180mm) Reel Specifications



Product size code	Units per Reel	Tape Width (mm)	C (mm)	D (mm)	W ₁ (mm)	W ₂ (mm)
Balun	4000	8	180.0±1.0	62±1.5	8.4+/-0.15	14.4 max

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Revision Control:

Revision	Date	Content	Remark
1	Feb. 12, 03	New issued K7 5050 and 50100 5050: 4711 714 00 245 50100: 4711 714 01 245	
2	Apr. 14, 03	Frequency characteristics re-drawn (on ENA)	
3	May 23, 03	Thickness T=0.85+-0.1 mm	
4	Aug 06, 03	50200 added, electrical specs. updated	
5	9th. Jan, 2004	Modify format of data sheet	

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